


<b>Search Notes</b> 	<b>Application/Control No.</b> 10576997	<b>Applicant(s)/Patent Under Reexamination</b> AVERKIOU ET AL.
	<b>Examiner</b> CRYSTAL I LEACH	<b>Art Unit</b> 3737

SEARCHED			
Class	Subclass	Date	Examiner
600	458	9/22/2008	CIL

SEARCH NOTES		
Search Notes	Date	Examiner
class/subclass search	9/22/2008	CIL
Inventors search	9/22/2008	CIL
text search	9/22/2008	CIL
see EAST Search History		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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Examiner,Art Unit 3737